

FLUKE.

Calibration

5322A

Multifunction Electrical Tester Calibrator

Product Specifications

October 2018 Rev. A

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Specifications

General Specifications

Specifications Confidence Level	99 %
Specifications Interval	1 year
Power Line	115/230 V ac (50/60 Hz) +10 % / -14 %, with the maximum voltage difference between neutral and protective earth not exceeding 15 V. Operation with power line between -10 % and -14 % has limitations in burden current for voltage outputs. See AC/DC Voltage Calibrator (VLC option) below.
Power Consumption	1250 VA maximum
⚠ Fuse Protection	
AC Mains Input	2 A, 250 V for 230 V, Time delay (T2L250 V – 5 mm x 20 mm) 4 A, 250 V for 115 V, Time delay (T4L250 V – 5 mm x 20 mm)
RCD input	3.15 A, 250 V, Fast (F3.15H250 V – 5 mm x 20 mm)
Meter amps (A) input	20 A, 500 V, Time delay (F20H500 V – 6.3 mm x 32 mm)
Loop/Line impedance input	4 A, 500 V, Time delay (T4H500 V – 6.3 mm x 32 mm)
Leakage current input	100 mA, 250 V, Fast (F100 mL250 V – 5 mm x 20 mm)

Environment

Warm-Up Time	15 minutes
Temperature Performance	
Operating Temperature	18 °C to 28 °C
Calibration Temperature (tcal)	23 °C
Temperature Coefficient	Temperature coefficient for temperature outside of tcal 5 °C between 5 °C to 40 °C is 0.1 x /°C of the specification
Storage Temperature	-10 °C to 50 °C
Storage Recovery Time	Typically <24 hours at operating temperature
Relative Humidity (operating)	<80 % to 28 °C (resistance outputs >10 GΩ specified for <70 % to 28 °C)
Relative Humidity (storage)	<90 % non-condensing 0 °C to 50 °C
Altitude	
Operating	3050 m (10 000 ft.)
Storage	12 200 m (40 000 ft)

Dimensions and Weight

Dimensions	430 mm x 555 mm x 170 mm (16.9 in x 21.8 in x 6.7 in)
Weight	20 kg (44.1 lb)

Compliance

Safety

Mains	IEC 61010-1: Overvoltage Category II, Pollution Degree 2
Measurement	IEC 61010-2-030: 5000 V (Not Category Rated)

Electromagnetic Compatibility (EMC)

International	IEC 61326-1: Basic Electromagnetic Environment CISPR 11: Group 1, Class A <i>Group 1: Equipment has intentionally generated and/or uses conductively-coupled radio frequency energy that is necessary for the internal function of the equipment itself.</i> <i>Class A: Equipment is suitable for use in all establishments other than domestic and those directly connected to a low-voltage power supply network that supplies buildings used for domestic purposes. There may be potential difficulties in ensuring electromagnetic compatibility in other environments due to conducted and radiated disturbances.</i> <i>Emissions that exceed the levels required by CISPR 11 can occur when the equipment is connected to a test object.</i>
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Korea (KCC)	Class A Equipment (Industrial Broadcasting & Communication Equipment)
<i>Class A: Equipment meets requirements for industrial electromagnetic wave equipment and the seller or user should take notice of it. This equipment is intended for use in business environments and not to be used in homes.</i>	
USA (FCC).....	47 CFR 15 subpart B. This product is considered an exempt device per clause 15.103.

Electrical Specifications

Low Resistance Source

Range 100 mΩ to 10 kΩ + 10 mΩ single value selection, dc and line frequency (50/60 Hz).

Setting Resolution 3½ digits (continuously variable)

Range of Lead Resistance Compensation 0 Ω to 2.000 Ω

Uncertainty and Maximum Ratings

Range	Resistance Source (Output)				Test Current Measurement	
	Resolution	Maximum AC rms or DC Current ^[1]	2-Wire Uncertainty ^{[1][2]} (tcal ±5 °C)	4-Wire Uncertainty ^[1] (tcal ±5 °C) ^[3]	Uncertainty ±(% reading + mA)	Resolution
10 mΩ ^[4]	-	1000 mA	-	1 % ^[3]	10 % + 10	10 mA
100 mΩ to 0.199 Ω	0.1 mΩ	700 mA	0.3 % + 50 mΩ	0.3 % + 10 mΩ	10 % + 10	1 mA
0.200 Ω to 0.499 Ω	1 mΩ	700 mA	0.3 % + 50 mΩ	0.3 % + 10 mΩ	10 % + 10	1 mA
0.500 Ω to 1.999 Ω	1 mΩ	700 mA	0.3 % + 50 mΩ	0.3 % + 10 mΩ	2 % + 10	1 mA
2.00 Ω to 4.99 Ω	1 mΩ	700 mA	0.3 % + 50 mΩ	0.3 % + 10 mΩ	1 % + 2	1 mA
5 Ω to 29.9 Ω	0.01 Ω	250 mA	0.2 % + 50 mΩ	0.2 % + 10 mΩ	0.2 %+1.0	1 mA
30 Ω to 199.9 Ω	0.1 Ω	100 mA	0.2 % + 50 mΩ	0.2 % + 10 mΩ	0.2 %+0.5	0.1 mA
200 Ω to 499 Ω	1 Ω	45 mA	0.2 %	0.2 %	0.2 %+0.2	0.1 mA
500 Ω to 1.999 kΩ	1 Ω	25 mA	0.2 %	0.2 %	0.2 %+0.1	0.1 mA
2 Ω to 4.99 kΩ	10 Ω	10 mA	0.2 %	0.2 %	0.2 %+0.1	0.1 mA
5 kΩ to 10 kΩ	10 Ω	5 mA	0.2 %	0.2 %	0.2 %+0.1	0.1 mA
<p>[1] Test current can exceed 120 % of maximum current for up to 3 seconds. Terminals automatically disconnect if test current exceeds 120 % of specified maximum current.</p> <p>[2] 2-Wire outputs are calibrated to the plane of the front panel terminals.</p> <p>[3] Uncertainty is valid to 200 mW. For higher power rating, add 0.1 % per each 300 mW above 200 mW.</p> <p>[4] Range is 4-wire only, 10 mΩ nominal, actual calibrated value is displayed. Calibration value uncertainty is specified in the table.</p>						

Test Current Measurement

Range 0 mA to 1000 mA (ac + dc) rms

Short Mode

Nominal Resistance in 2-Wire <100 mΩ

Maximum Current 1000 mA (ac + dc) rms

Open Mode

Nominal Resistance 30 MΩ ±20 %

Maximum Input Voltage Allowed 50 V (ac + dc) rms

Test Voltage Reading 0 V to 50 V (ac + dc) rms

Resolution 1 V

Uncertainty ± (5 % + 2 V)

Lead Resistance Simulation (4-Wire Mode)

Nominal Resistance..... 500 Ω , 1 k Ω , 2 k Ω , 5 k $\Omega \pm 2\%$, inserted as pairs. One resistor of the pair is in series with the LO-OHM Hi terminal, and the other resistor is in series with LO-OHM Hi Sense terminal

1.5 KV High Resistance Source (DC Only)

Range..... 10 k Ω to 10 G Ω + 100 G Ω single value selection

Resolution 4½ Digit (continuously variable for 10 k Ω to 10 G Ω range)

Uncertainty and Maximum Ratings

Range	Resistance Source (Output)			Test Voltage Measurement	
	Resolution	Maximum Voltage DC	Uncertainty ^[1,2] (tcal $\pm 5^\circ C$)	Uncertainty $\pm (\% \text{ reading} + V)$	Resolution
10.000 k Ω to 19.999 k Ω	1 Ω	55 V	0.2 %	0.3 % + 2	0.1 V
20.00 k Ω to 39.99 k Ω	10 Ω	55 V	0.2 %	0.3 % + 2	0.1 V
40.00 k Ω to 99.99 k Ω	10 Ω	400 V	0.2 %	0.3 % + 2	0.1 V
100.00 k Ω to 199.99 k Ω	10 Ω	800 V	0.2 %	0.3 % + 2	0.1 V
200.0 k Ω to 999.9 k Ω	100 Ω	1100 V	0.2 %	0.3 % + 2	0.1 V
1.000 0 to 1.999 9 M Ω	100 Ω	1150 V	0.3 %	0.5 % + 5	0.1 V
2.000 M Ω to 9.999 M Ω	1 k Ω	1150 V	0.3 %	0.5 % + 5	0.1 V
10.000 M Ω to 19.999 M Ω	1 k Ω	1575 V	0.5 %	0.5 % + 5	0.1 V
20.00 M Ω to 199.99 M Ω	10 k Ω	1575 V ^[3]	0.5 %	0.5 % + 5	0.1 V
200.0 M Ω to 999.9 M Ω	100 k Ω	1575 V ^[3]	0.5 %	0.5 % + 5	0.1 V
1.0000 G Ω to 1.9000 G Ω	100 k Ω	1575 V ^[3]	1.0 %	1 % + 5	0.1 V
2.000 G Ω to 10.000 G Ω	1 M Ω	1575 V ^[3]	1.0 %	1 % + 5	0.1 V
100 G Ω	-	1575 V ^[3]	3.0 % ^[4]	1.5 % + 5	0.1 V

[1] Uncertainty is valid up to 500 V. For test voltages above 500 V, add 0.1 % for each 200 V above 500 V.
[2] Uncertainty is valid for relative humidity RH $\leq 50\%$. For operation at ambient RH in the range 50 % to 80 % and resistance output values 100.0 M Ω to 9.99 G Ω , add 0.02 x specified uncertainty/ % RH. For resistance output values 10.00 G Ω to 100.0 G Ω , add 0.05 x specified uncertainty / % RH up to 70 %.
[3] Maximum test voltage with the supplied banana leads is 1000 Vrms. For higher voltages, use leads rated at 1575 V or above.
[4] Calibrated value uncertainty is specified in the table. Nominal value is $\pm 15\%$.

Test Voltage Measurement

Range..... 1200 V dc in resistance range from 10 k Ω to 1 M Ω
2000 V dc in resistance range 1 M Ω to 100 G Ω

Settling Time 2 seconds for input deviations of <5 %

Test Current Measurement

Range..... 0 mA dc to 9.9 mA dc

Uncertainty $\pm(1.5\% + 5V/R A)$, where R is the selected resistance value

Settling time 2 seconds (for voltage reading deviations <5 %)

Short Mode

Nominal resistance	<250 Ω
Maximum input current allowed	50 mA dc
Test current range	0 mA dc to 50 mA dc
Resolution	0.1 mA
Uncertainty	$\pm(2\% + 0.5 \text{ mA})$

Open Mode

Nominal resistance	100 G Ω $\pm 15\%$
Maximum input voltage allowed	1575 V dc
Test voltage reading	0 V dc to 2000 V dc
Resolution	0.1 V
Uncertainty	$\pm(1\% + 1 \text{ V})$

Resistance Multiplier Adapter (x1000 Multiplier)

Resistance range	350 M Ω to 10 T Ω
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Uncertainty and Maximum Ratings

Range	Resolution	Maximum Voltage DC	Uncertainty (tcal $\pm 5^\circ\text{C}$)
350.0 M Ω to 99.99 G Ω	100 k Ω	10 000 V	$\pm(1.0\% + R^{[1]})$
100.00 G Ω to 999.9 G Ω	10 M Ω	10 000 V	$\pm(2.0\% + R^{[1]})$
1.0000 T Ω to 10.000 T Ω	100 M Ω	10 000 V	$\pm(3.0\% + R^{[1]})$

[1] R is the uncertainty of the 5322A resistance value that is multiplied by 1000.

5.5 kV High Resistance Source (DC Only) (5322A with /5 Option)

Range	10 k Ω to 100 G Ω
Resolution	4½ Digit (continuously variable)

Uncertainty and Maximum Ratings

Range	Resistance Source (Output)			Test Voltage Measurement	
	Resolution	Maximum Voltage DC	Uncertainty ^[1, 2] (tcal ±5 °C)	Uncertainty ±(% reading + V)	Resolution
10.000 kΩ to 19.999 kΩ	1 Ω	65 V	±0.2 %	0.5 % + 2	0.1 V
20.00 kΩ to 39.99 kΩ	10 Ω	65 V	±0.2 %	0.5 % + 2	0.1 V
40.00 kΩ to 99.99 kΩ	10 Ω	400 V	±0.2 %	0.5 % + 2	0.1 V
100.00 kΩ to 199.99 kΩ	10 Ω	800 V	±0.2 %	0.5 % + 10	1 V
200.0 kΩ to 999.9 kΩ	100 Ω	1100 V	±0.2 %	0.5 % + 10	1 V
1.000 MΩ to 1.999 MΩ	1 kΩ	1575 V	±0.3 %	0.5 % + 10	1 V
2.000 MΩ to 9.999 MΩ	1 kΩ	2500 V	±0.3 %	0.5 % + 10	1 V
10.000 MΩ to 19.999 MΩ	1 kΩ	5500 V ^[3]	±0.5 %	0.5 % + 10	1 V
20.00 MΩ to 199.99 MΩ	10 kΩ	5500 V ^[3]	±0.5 %	0.5 % + 10	1 V
200.0 MΩ to 999.9 MΩ	100 kΩ	5500 V ^[3]	±0.5 %	0.5 % + 10	1 V
1.0000 GΩ to 1.9999 GΩ	100 kΩ	5500 V ^[3]	±1.0 %	0.5 % + 10	1 V
2.000 GΩ to 9.999 GΩ	1 MΩ	5500 V ^[3]	±1.0 %	0.5 % + 10	1 V
10.000 GΩ to 19.999 GΩ	1 MΩ	5500 V ^[3]	±3.0 %	0.5 % + 10	1 V
20.00 GΩ to 100.00 GΩ	10 MΩ	5500 V ^[3]	±3.0 %	0.5 % + 10	1 V
<p>[1] Uncertainty is valid to 3000 V. For test voltages above 3000 V, add 0.1 % for each 1000 V above 3000 V in range 10.00 MΩ to 999 MΩ and 0.3 % in range 1.000 GΩ to 100.0 GΩ.</p> <p>[2] Uncertainty is valid for relative humidity RH ≤50 %. For operation at ambient RH in the range 50 % to 80 % and resistance output values 100.0 MΩ to 9.99 GΩ, add 0.02 x specified uncertainty/ % RH. For resistance output values 10.00 GΩ to 100.0 GΩ, add 0.05 x specified uncertainty / % RH up to 70 %.</p> <p>[3] Maximum test voltage with the supplied banana lead is 5000 Vrms. For higher voltages, use leads rated at ≥5000 V.</p>					

Test Voltage Measurement

Range 0 V dc to 5500 V dc

Test voltage indication 4 digit voltmeter with range:

1200 V dc in resistance range 10.00 kΩ to 1.000 MΩ

2600 V dc in resistance range 1.000 MΩ to 10.00 MΩ

5500 V dc in resistance range 10.00 MΩ to 100.0 GΩ

Settling Time 2 seconds for input deviations of <5 %

Test Current Measurement

Range 0 mA dc to 9.9 mA dc

Uncertainty ±(1.5 % + 5V/R A), where R is the selected resistance value

Settling Time 2 seconds (for voltage reading deviations <5 %)

Short Mode

Nominal Resistance <250 Ω

Maximum Input Current Allowed 50 mA dc

Test Current Range 0 mA dc to 50 mA dc

Resolution 0.1 mA

Uncertainty ±(2 % + 0.5 mA)

Open Mode

Nominal Resistance	100 GΩ ±15 %
Maximum Input Voltage Allowed	5500 V dc
Test Voltage Range	0 Vpk to 5500 V dc
Resolution	0.1 V ≤ 400 V input, 1 V > 400 V input
Uncertainty	0.5 % + 10 V

Ground Bond Resistance Source**Resistance Mode**

Range	1 mΩ to 1700 Ω, dc and line frequency (50/60 Hz).
Resolution	17 discrete values
Test Current Measurement Range	0 A to 30 A (ac + dc) rms
Test Current Measurement Resolution	0.01 mA to 10 mA depending on resistance output and test current
Range of lead resistance compensation	0 Ω to 2.000 Ω

Uncertainty and Maximum Ratings

2-Wire Nominal Value	4-Wire Nominal Value	Resistance Source (Output)				4-Wire Absolute Uncertainty of Characterized Value (tcal ± 5 °C)	Test Current Measurement		
		Deviation from Nominal Value (both 2-Wire and 4-Wire)	Maximum Continuous Test Current AC rms or DC (Lo, Hi) [1]	Days Since Relay Cleaning					
				7 Days	90 Days				
	1 mΩ	±20 %	3 A 30 A	--	--	±0.2 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
20 mΩ	14 mΩ	±50 %	3 A 30 A	±8 mΩ	±12 mΩ	±0.40 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
50 mΩ	39 mΩ	±50 %	2.8 A 28 A	±8 mΩ	±12 mΩ	±0.70 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
100 mΩ	94 mΩ	±30 %	2.5 A 25 A	±8 mΩ	±12 mΩ	±1.2 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
350 mΩ	340 mΩ	±20 %	1.4 A 14 A	±8 mΩ	±14 mΩ	±2.0 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
500 mΩ	490 mΩ	±10 %	1.2 A 12 A	±8 mΩ	±15 mΩ	±2.7 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
960 mΩ	960 mΩ	±10 %	0.8 A 8 A	±10 mΩ	±20 mΩ	±4.8 mΩ	4 A/1 mA 40 A/10 mA 1 % + 12 1 % + 120		
1.7 Ω	1.7 Ω	±10 %	0.6 A 6 A	±13 mΩ	±25 mΩ	±8.5 mΩ	3 A/1 mA 30 A/10 mA 0.3 % + 9 0.3 % + 90		
4.7 Ω	4.7 Ω	±10 %	0.32 A 3.2 A	±30 mΩ	±37 mΩ	±24 mΩ	2.1 A/1 mA 21 A/10 mA 0.3 % + 7 0.3 % + 70		
9 Ω	9 Ω	±10 %	0.2 A 2 A	±50 mΩ	±60 mΩ	±45 mΩ	1.5 A/1 mA 15 A/10 mA 0.3 % + 4 0.3 % + 40		
17 Ω	17 Ω	±10 %	0.15 A 1.5 A	±90 mΩ	±100 mΩ	±45 mΩ	1 A/1 mA 10 A/10 mA 0.3 % + 3 0.3 % + 30		
47 Ω	47 Ω	±10 %	0.08 A 0.8 A	±250 mΩ	±300 mΩ	±300 mΩ	0.5 A/0.1 mA 5 A/1 mA 0.3 % + 1.5 0.3 % + 15		
90 Ω	90 Ω	±10 %	0.05 A 0.5 A	±450 mΩ	±500 mΩ	±500 mΩ	0.3 A/0.1 mA 3 A/1 mA 0.3 % + 1.0 0.3 % + 10		
170 Ω	170 Ω	±10 %	0.025 A 0.25 A	±1 Ω	±1 Ω	±1 Ω	0.13 A/0.1 mA 1.35 A/1 mA 0.3 % + 0.5 0.3 % + 5		
470 Ω	470 Ω	±10 %	0.01 A 0.10 A	±2.5 Ω	±2.5 Ω	±2.5 Ω	0.06 A/0.01 mA 0.6 A/0.1 mA 0.3 % + 0.25 0.3 % + 2.5		
900 Ω	900 Ω	±10 %	0.005 A 0.05 A	±5 Ω	±5 Ω	±5 Ω	0.03 A/0.01 mA 0.3 A/0.1 mA 0.3 % + 0.15 0.3 % + 1.5		
1700 Ω	1700 Ω	±10 %	0.003 A 0.03 A	±10 Ω	±10 Ω	±10 Ω	0.015 A/0.01 mA 0.150 A/0.1 mA 0.3 % + 0.07 0.3 % + 0.7		

[1] Test currents up to 30 % of maximum continuous test current can be applied to the Calibrator with no time limitation. Test current between 30 % and 100 % of the maximum continuous test current can be applied to the Calibrator for a limited time. The Calibrator calculates the allowed time period and when exceeded, the output connectors are disconnected. Minimum period of full current load is 45 seconds.

Open Mode

Nominal Resistance	>100 kΩ
Maximum Voltage	50 V (ac + dc) rms
Test Voltage Range	0 V to 50 V (ac + dc) rms
Resolution	1 V
Uncertainty	2 % + 2 V

Line/Loop Impedance Source

Range	25 mΩ to 1700 Ω
Resolution	16 discrete values
Range of lead resistance compensation	0 Ω to 2.000 Ω

Uncertainty and Maximum Ratings

Nominal Resistance Value	Deviation from Nominal Value	Absolute Uncertainty of Characterized Value (tcal ±5 °C)		Maximum Continuous Test Current AC rms or DC [1]	Maximum Short-term Test Current AC rms or DC [2]	Test Current Uncertainty ±(% reading + mA)	Test Current Resolution				
		Days Since Relay Cleaning									
		7 Days	90 Days								
20 mΩ	±50 %	±8 mΩ	±12 mΩ	30 A	40 A	1.5 % + 0.7 A	100 mA				
50 mΩ	±50 %	±8 mΩ	±12 mΩ	28 A	40 A	1.5 % + 0.5 A	100 mA				
90 mΩ	±30 %	±8 mΩ	±12 mΩ	25 A	40 A	1.5 % + 0.35 A	100 mA				
350 mΩ	±20 %	±8 mΩ	±14 mΩ	14 A	40 A	1.5 % + 0.3 A	100 mA				
500 mΩ	±10 %	±8 mΩ	±15 mΩ	12 A	40 A	1.5 % + 0.2 A	100 mA				
0.96 Ω	±10 %	±10 mΩ	±20 mΩ	8 A	40 A	1.5 % + 150 mA	10 mA				
1.7 Ω	±10 %	±13 mΩ	±25 mΩ	6 A	30 A	1.5 % + 100 mA	10 mA				
5 Ω	±10 %	±30 mΩ	±37 mΩ	3.2 A	21 A	1.5 % + 70 mA	10 mA				
9 Ω	±10 %	±50 mΩ	±60 mΩ	2.0 A	15 A	1.5 % + 50 mA	10 mA				
17 Ω	±10 %	±90 mΩ	±100 mΩ	1.5 A	10 A	1.5 % + 30 mA	10 mA				
50 Ω	±10 %	±250 mΩ	±300 mΩ	0.8 A	5.0 A	1.5 % + 20 mA	1 mA				
90 Ω	±10 %	±450 mΩ	±500 mΩ	0.5 A	3.0 A	1.5 % + 10 mA	1 mA				
170 Ω	±10 %	±1 Ω	±1 Ω	0.25 A	1.35 A	1.5 % + 5 mA	1 mA				
500 Ω	±10 %	±2.5 Ω	±2.5 Ω	0.1 A	0.6 A	1.5 % + 3 mA	1 mA				
900 Ω	±10 %	±5 Ω	±5 Ω	0.05 A	0.3 A	1.5 % + 2 mA	1 mA				
1.7 kΩ	±10 %	±10 Ω	±10 Ω	0.030 A	0.15 A	1.5 % + 2 mA	1 mA				

[1] Test currents up to 30 % of maximum continuous test current can be applied to the Calibrator with no time limitation. Test current between 30 % and 100 % of the maximum continuous test current can be applied to the Calibrator for a limited time. Minimum period of full current load is 45 seconds. The Calibrator calculates the allowed time period and when exceeded, the output connectors are disconnected.

[2] Maximum short term test current is defined as the rms value of halfwave or fullwave test current flowing through the Device Under Test (DUT). Maximum time of test is 200 ms. A time interval of 200 ms represents 10 full waves of power line voltage at 50 Hz and 12 full waves at 60 Hz.

Test Current Measurement

Type Of Recognized Test Current Positive impulse (halfwave), negative impulse (halfwave), symmetrical (fullwave).
Range 0 A to 40 A (ac + dc) rms

Prospective Fault Current

Range 0 kA to 10 kA

Correction Manual Mode

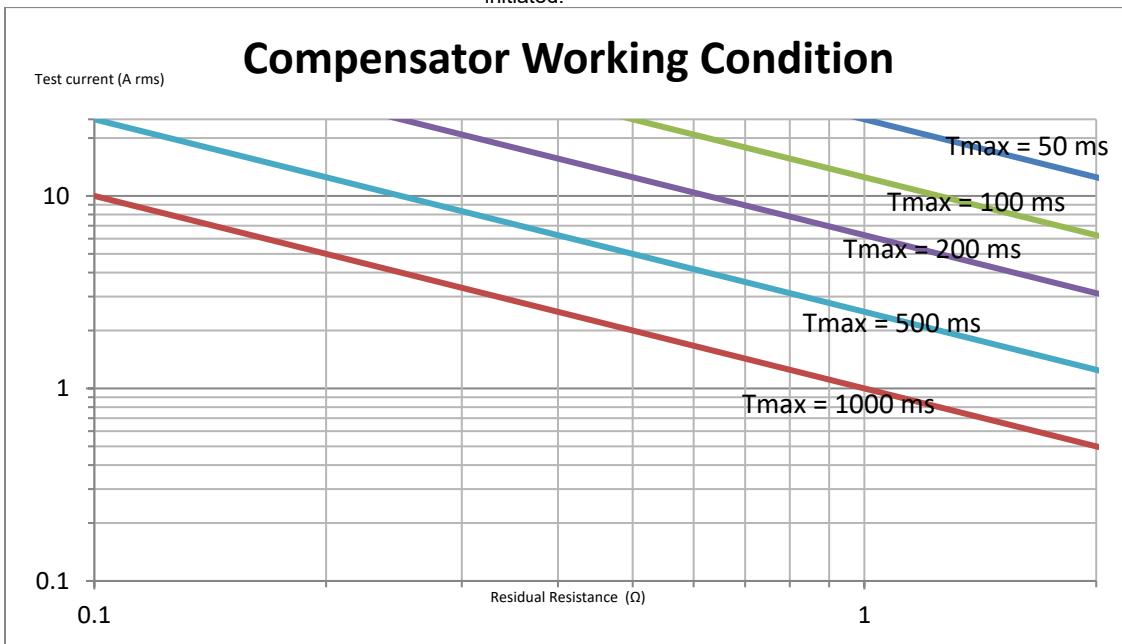
Residual Impedance Range 0 Ω to 10 Ω
Resolution 1 mΩ
Uncertainty Uncertainty in manual (MAN) mode is the uncertainty of the selected resistance value. See Uncertainty and Maximum Range table above. Also, take into consideration the uncertainty of any manually-entered correction.

Correction Scan Mode

Residual Impedance Range 0 Ω to 10 Ω
Resolution 1 mΩ
Uncertainty ±(1 % +15 mΩ + uncertainty of selected resistance value).

Correction COMP Mode (Active Loop Compensation) (5322A/VLC Option)

Maximum Compensated Impedance 0 Ω to 2 Ω, see graph below for details
Maximum Test Current <25 A, see graph below for details
Uncertainty Of Compensation ±(1 % + 15 mΩ + uncertainty of selected resistance value).
 Uncertainty is valid at the point in time when the COMP function is initiated.



Residual Resistance is the value of resistance which the Compensator can correct for based on the test current level sourced by the Device Under Test (DUT). The Tmax parameter is the maximum time the Compensator can correct the Residual Resistance before an overload condition is detected.

Leakage Current Source

Range 0.1 mA to 30 mA

Resolution

Passive Mode 10 μA setting, 1 μA measurement
 Differential Mode 10 μA setting, 1 μA measurement
 Substitute Mode 10 μA
 Active Mode (5322A/VLC only)^[1] 10 μA

Test Voltage

Passive Mode	60 V ac rms to 250 V ac rms
Differential Mode.....	60 V ac rms to 250 V ac rms
Substitute Mode.....	10 V ac rms to 250 V ac rms
Active Mode (5322A/VLC only) ^[1]	50 V ac rms to 100 V ac rms

Uncertainty

Passive Mode	$\pm(0.3\% \text{ setting} + 2 \mu\text{A})$
Differential Mode.....	$\pm(0.3\% \text{ setting} + 2 \mu\text{A})$
Substitute Mode.....	$\pm(0.3\% \text{ setting} + 2 \mu\text{A})$
Active Mode (5322A/VLC only) ^[1]	$\pm(0.3\% \text{ setting} + 1 \mu\text{A})$

[1] The Active Mode outputs are synchronized with the ac mains frequency to suppress interference between the Calibrator and external noise sources.

Substitute Mode SHORT

Input resistance	<150 Ω
Test current range	50 mA
Test current uncertainty	$\pm(0.5\% \text{ reading} + 10 \mu\text{A})$ OPEN mode input

Substitute Mode OPEN

Input resistance	$30 \text{ M}\Omega \pm 5\%$
Touch voltage range	50 V
Touch voltage uncertainty.....	$\pm(2\% \text{ reading} + 1 \text{ V})$

Human Body Simulation (for substitute leakage current only)

Resistance range.....	0 Ω to 10 000 Ω
Resolution	1 Ω

RCD (Residual Current Device) (for Installation Testers)**Trip Current Range**

0.5 X I and 1 X I Mode	3 mA rms to 3000 mA rms in 1 mA steps
1.4 X I and 2 X I Mode	3 mA rms to 1500 mA rms in 1 mA steps
5 X I Mode	3 mA rms to 600 mA rms in 1 mA steps

Trip Current Measurement Resolution

1 μA below 30 mA	
10 μA in range from 30 mA to 300 mA	
100 μA in range from 300 mA to 3 A	

Trip Current Measurement Uncertainty

Trip Current..... $\pm 1\% \text{ of nominal current (I) setting}$

Trip Time Range.....10 ms to 5000 ms

Trip Time Uncertainty.....(0.02 % setting + 0.25 ms)

Touch/Line Voltage

Touch voltage range	50 V
Touch voltage setting.....	in discrete points depending on setup trip current value
Touch series resistance.....	0.02 Ω , 0.05 Ω , 0.10 Ω , 0.35 Ω , 0.50 Ω , 0.96 Ω , 1.7 Ω , 4.7 Ω , 9 Ω , 17 Ω , 47 Ω , 90 Ω , 170 Ω , 470 Ω , 900 Ω , 1700 Ω
Line Voltage Range	250 V
Line Voltage Uncertainty.....	$\pm(5\% \text{ reading} + 3 \text{ V})$

User selectable nominal line voltage 100 V/115 V/120 V/220 V/230 V/240 V/250 V or Real
Post-trip delayed power restore mode.....User selectable

RCD (Residual Current Device) (for PATs)**Trip Current Range**

0.5 X I and 1 X I Mode	5 mA to 30 mA in 1 mA steps
1.4 X I and 2 X I Mode	14 mA to 60 mA in 1 mA steps
5 X I Mode	50 mA to 150 mA in 1 mA steps

Trip Current Measurement Resolution	1 µA below 30 mA 10 µA in range from 30 mA to 150 mA
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Trip Current Measurement Uncertainty

Trip Current.....	±1 % of nominal current (I) setting
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Trip Time Range	10 ms to 5000 ms
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Trip Time Uncertainty	(0.02 % setting + 0.25 ms)
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Line Voltage

Line Voltage Range	250 V
Line Voltage Uncertainty.....	±(5 % reading + 3 V)
User selectable nominal line voltage	100 V/115 V/120 V/220 V/230 V/240 V/250 V or Real
Automatic Reconnection after tripping.....	Off/On
Reconnection delay	2.5 s

AC/DC Voltage Calibrator (5322A with VLC Option)

Range	0.03 V to 600 V, ac or dc
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Resolution	4 digits
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Internal Ranges

AC Mode	0.3 V, 3 V, 30 V, 100 V, 300 V, and 600 V (Autoranging only)
DC Mode.....	0.3 V, 3 V, 30 V, 150 V, and 600 V (Autoranging only)
Output Resistance	<1 Ω

Frequency

Range	40 Hz to 400 Hz
Resolution.....	3 digits
Uncertainty.....	0.02 %

Settling Time	<3 s to specified accuracy
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AC Voltage**Uncertainty and Maximum Burden Current**

Range	Resolution	Uncertainty ±(% of Output + mV)	Maximum Burden Current
30.00 mV to 300.00 mV	0.01 mV	0.5 % + 1	2 mA
0.3001 V to 3.0000 V	0.0001 V	0.3 % + 3	2 mA
3.001 V to 30.000 V	0.001 V	0.1 % + 9	500 mA
30.01 V to 100.00 V	0.1 V	0.1 % + 30	300 mA
100.01 V to 300.00 V	0.01 V	0.1 % + 90	250 mA ^[1]
300.01 V to 600.00 V	0.01 V	0.1 % + 180	50 mA

[1] 200 mA when power line is between -10 % and -14 % of nominal.

DC Voltage**Uncertainty and Maximum Burden Current**

Range	Resolution	Uncertainty ±(% of Output + mV)	Maximum Burden Current
30.00 mV to 300.00 mV	0.01 mV	0.5 % + 1	2 mA
0.3001 V to 3.0000 V	0.0001 V	0.3 % + 3	2 mA
3.001 V to 30.000 V	0.001 V	0.1 % + 9	2 mA
30.01 V to 150.00 V	0.01 V	0.1 % + 45	3 mA
150.01 V to 600.00 V	0.01 V	0.1 % + 180	5 mA

AC Output Signal Distortion 0.2 % +10 mV (harmonic distortion and non-harmonic noise in frequency range from 20 Hz to 500 kHz), for output power up to 10 VA on each range.

Sensing Ammeter Current Range 500 mA ac

Resolution 1 mA

Uncertainty ±5 mA

Multimeter

Maximum Withstand Voltage

HV terminal to COM terminal 5000 V rms

V terminal to COM terminal 1100 V rms

COM terminal to Protective Earth 2200 V pk

AC/DC Voltage

Range

V (1100 V) Input: 0 V dc to ±1100 V dc
10 mV to 1100 V ac rms

HV (5000 V) Input: 0 Vdc to ±5000 Vdc
5 V to 5000 V ac rms

Resolution 4 digits

Frequency Range

V input DC, 20 Hz to 2 kHz

HV input: DC, 20 Hz to 100 Hz

Input Resistance 10 MΩ ±1 % on 10, 100, 1100 V ranges (V input terminal)

120 MΩ ±1 % on 5000 V rms / 5000 V dc ranges (HV input terminal)

Settling time 1.5 s below 1100 V, 3 s above 1100 V to 1 % floor to specified accuracy

Readings/Second 2

Rolling Average 1, 2, 4, 8, 16 readings

Measurement Category CAT II

CMRR -75 dB (dc, 50 Hz or 60 Hz)

AC/DC Voltage Uncertainty

Ranges	Resolution	Uncertainty (dV) ±(% of Reading + mV)
10 V ac/dc	0.001 V	0.15 % + 5
100 V ac/dc	0.01 V	0.20 % + 50
1100 V ac/dc	0.1 V	0.20 % + 550
5000 V rms/5000 V dc	1 V	0.30 % + 5500

AC/DC Current

Range 0 A to 20 A continuous, 20 A to 30 A for up to 5 minutes, ac rms or dc

Resolution 4½ digits

Internal Ranges 300 mA, 3 A and 30 A (Autoranging only)

Frequency Range dc, 20 Hz to 400 Hz

Settling time 1.5 s to 1 % floor to specified accuracy

Readings/Second 2

Rolling Average 1, 2, 4, 8, 16 readings

AC/DC Current Uncertainty

Range	Resolution	Uncertainty (dI) ±(% of Reading + mA) [1]	Input Resistance
300 mA ac/dc	0.1 mA	0.15 % + 0.15	500 mΩ
3 A ac/dc	1 mA	0.15 % + 1.5	75 mΩ
30 A ac/dc	10 mA	0.30 % + 15	25 mΩ

[1] Uncertainty specification is valid when voltage between the COM terminal to protective earth is <20 V rms.

AC Power

Range	0 kVA ac to 33 kVA ac
Voltage Range	0 V ac to 1100 V ac
Current Range	0 A ac to 30 A ac
Frequency Range	40 Hz to 65 Hz
Type	apparent, active, reactive
Resolution	3½ digits
Phase Indication	Phase angle (ϕ), Power Factor (PF)
Phase Uncertainty (dϕ)	$\pm 0.1^\circ$

Power Uncertainty

Active Power Uncertainty: $dPW = \sqrt{ (dV^2 + dI^2 + dPF^2) } \%$
 Reactive Power uncertainty calculation: $dPVAR = \sqrt{ (dV^2 + dI^2 + dPFVAR^2) } \%$
 Apparent Power uncertainty calculation: $dPVA = \sqrt{ (dV^2 + dI^2) } \%$
 Where $dPF = \text{abs}(100 * (1 - \cos(\phi + d\phi) / \cos \phi)) \%$
 $dPFVAR = \text{abs}(100 * (1 - \sin(\phi + d\phi) / \sin \phi)) \%$
 ϕ is measured phase [°]
 dV is the uncertainty of the measured voltage [%]
 dI is the uncertainty of measured current [%]
 d ϕ is the uncertainty of measured phase [°]

DC Power

Range	0 to 33 kVA dc
Voltage range	0 to 1100 V dc
Current range	0 to 30 A dc
Resolution	3½ digits
Power Uncertainty	$PW = \sqrt{ (dV^2 + dI^2) } \%$ dV is the uncertainty of the measured voltage [%] dI is the uncertainty of the measured current [%]

Hipot Leakage Current Measurement Mode

Range	0 mA ac rms or dc to 300 mA ac rms or dc
Resolution	4½ digits
Frequency range	DC, 20 Hz to 400 Hz
Time constant	1.5 s
Readings/second	2

Hipot Leakage Current Mode Uncertainty

Range	Resolution	Uncertainty $\pm (\% \text{ of reading} + \mu\text{A})$ [¹]
300 uA	0.01 μA	0.3 % + 0.2
3 mA	0.1 μA	0.2 % + 1.5
30 mA	1 μA	0.2 % + 15
300 mA	10 μA	0.2 % + 150

[¹] Uncertainty specification is valid when voltage between the COM terminal to Protective Earth is <20 V rms.

Hipot Timer Measurement Mode

Range	0.1 s to 999 s
Resolution	1 ms
Uncertainty	dc $\pm (0.02 \% \text{ reading} + 2 \text{ ms})$ ac $\pm (0.02 \% \text{ reading} + 20 \text{ ms})$
Threshold voltage adjustment	10 % to 99 % of applied voltage range
Adjustment resolution	1 %

Hipot AC Voltage Distortion Measurement

Frequency Range	45 Hz to 65 Hz
Number of harmonics	25
Voltage Range	10 V to 5000 V rms
THD Range	0 % to 10 %
THD Resolution	3½ digits
Uncertainty	±0.5 % THD

Hipot DC Voltage Ripple Coefficient Measurement

Voltage Range	100 V dc to 5000 V dc
Ripple Coefficient Range	10 %
Resolution	3½ digits
Uncertainty (Relative Ripple Coefficient)	±0.5 % Ripple Coefficient
Uncertainty (Absolute Ripple Coefficient)	±0.5 % of total voltage (dc + ac) measured

Note

Relative Ripple Coefficient is defined by the ratio V ac rms/V dc expressed in % where V ac rms is the root mean square of the ac signal contained in the test voltage. V dc is the average measured dc value of the test voltage.

Absolute Ripple Coefficient is defined by the difference between the minimum and maximum measured dc level.

Flash Test Voltage Measurement (Using Flash LC or Flash V Mode)

Class I Voltage Range	2000 V ac rms
Uncertainty	±(0.3 % of reading + 6 V)
Class II Voltage Range	3000 V ac rms
Uncertainty	±(1 % of reading value + 6 V)

Flash Leakage Current Measurement (Using Flash LC Mode)

Range	0 mA ac rms or dc to 300 mA ac rms or dc
Resolution	4½ digits

Flash Leakage Current Mode Uncertainty

Range	Resolution	Uncertainty ±(% of reading + µA) ^[1]
300 µA	0.01 µA	0.3 % + 0.2
3 mA	0.1 µA	0.2 % + 1.5
30 mA	1 µA	0.2 % + 15

^[1] Uncertainty specification is valid when voltage between the COM terminal to Protective Earth is <20 V rms.

10 kV Divider (1000:1 Voltage Divider)

Range	0 kV ac peak/dc to 10 kV ac peak/dc
Resolution	4½ digits
Uncertainty	0.3 % of value + 5 V dc 0.5% of value + 10 V ac at 50 Hz or 60 Hz

80K-40 High Voltage Probe (1000:1 Voltage Divider)

Range	0 kV ac peak/dc to 40 kV ac peak/dc
Resolution	4½ digits
Uncertainty	dc: ±(0.5 % of input + 10 V) ac: ±(1.0 % of input + 10 V) at 50 Hz or 60 Hz

Note

Uncertainty specification applies to probes calibrated with the 5322A and includes specification for probe division ratio and input impedance of the Meter.

5322A

Product Specifications